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SHEET 3 OF 7 FORM PTO-1449 (SUBSTITUTE) Attomey Docket No.: Serial No. GR 96 P 1650 P 09/221,789 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **Applicant** Ulrike Reeh et al. INFORMATION DISCLOSURE STATEMENT BY APPLICANT Filing Date **Group Art Unit** (37 CFR 1.98(b) HOY December 28, 1998 2815 **U.S. PATENT DOCUMENTS EXAMINER** SUB FILING INITIALS PATENT NO. DATE PATENTEE CLASS CLASS DATE Α В C D Ε F G Н ١ FOREIGN PATENT DOCUMENT SUB TRANSL. DOCUMENT NO. DATE COUNTRY CLASS CLASS YES I NO Κ L M Ν OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) Thomas Jüstel et al.: "Neue Entwickungen auf dm Gebiet lumineszierender Materialien für Beleuchtungs- und Displayanwendungen\* [new developments in the field of luminescent materials for lighting and display applications]. Angew. Chem. 1998, 110 pp. 3250-3271 D.J. Robbins: "The Effects of Crystal Field and Temperature on the Photoluminescence Excitation of Ce<sup>3</sup>" in YAG", J. Electrochem. Soc.: Solid State Science and Technology, September 1979, Vol. 126, No. 9, pp.1550-1555 EXAMINER DATE CONSIDERED 00 EXAMINER: Initial in election considered, whether or not citation is in conformance with MPEP 609; Draw line through sitation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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G. Blasse et al.: "A New Phosphor For Flying-Spot Cathode-Ray Tubes For Color Television: Yellow-Emitting Y<sub>3</sub>Al<sub>5</sub>O<sub>12</sub>-Ce<sup>3+</sup>", Applied Physics Letter, Vol. 11, No. 2, 15 Jhuly 1967, pp. 53,54

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SHEET 6 OF 7 FORM PTO-1449 (SUBSTITUTE) Attorney Docket No.: Serial No. GR 96 P 1650 P 09/221,789 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **Applicant** Ulrike Reeh et al. INFORMATION DISCLOSURE STATEMENT BY APPLICANT Filing Date **Group Art Unit** (37 CFR 1.98(b) December 28, 1998 2815 **U.S. PATENT DOCUMENTS EXAMINER** SUB FILING INITIALS PATENT NO. DATE PATENTEE CLASS **CLASS** DATE Α В C D Ε F G Н FOREIGN PATENT DOCUMENT SUB TRANSL. DOCUMENT NO. DATE COUNTRY CLASS **CLASS** YES | NO K L M Ν OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) ō Mary V. Hoffman: "Improved color rendition in high pressure mercury vapor lamps", Journal of IES, January 1977, pp. 89-91 B. M. J. Smets: "Phosphors Based On Rare-Earths, A New Era in Fluorescent Lighting", Materials Chemistry and Physics, 16 (1987), pp. 283-299

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Substitute Disclosure Form (PTO-1449)

Substitute Form PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Information Disclosure Statement

By Applicant

Ulrike Reeh et al.

Filing Date

December 28, 1998

Application No. 09/221,789

Applicant

Ulrike Reeh et al.

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Substitute Disclosure Form (PTO-1449)

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by Applicant (Use several sheets if necessary)

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Application No. 09/221,789

Applicant

Ulrike Reeh et al.

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Examiner	Desig.	Document	Publication	Country or			Transla	ation
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K	DB	03287690	12/18/1991	Japan			Abstract Only	
	DC	05315652	11/26/1993	Japan			Abstract Only	
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information Disclosure Statement by Applicant Use several sheets if necessary)	Applicant Ulrike Reeh et al.		
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		EB	JP 46-39866	06/12/1973	Japan				7
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(See Several sheets if necessary)	Filing Date December 28, 1998 Group Art Unit		

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 12406-003001

Application No. 09/221,789

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Filing Date
December 28, 1998

Group Art Unit 2815

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b)

Attomey	Do	ocket	No.:
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Serial No.

09/221,789

**Applicant** 

Ulrike Reeh et al.

Filing Date

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December 28, 1998

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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	∴ No
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